

Notice of References Cited	Application/Control No. 10/525,770	Applicant(s)/Patent Under Reexamination SHIRAI ET AL.	
	Examiner Khoa D. Huynh	Art Unit 3751	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-4,581,779	04-1986	Matsui et al.	4/420.2
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